NANO 703/703L Homework 5 Due: M-12/5, 10:00 AM

1) A CBED pattern acquired at 200 KeV shows a FOLZ ring (n=1) with diameter $2G_1 = 46.4 \text{ nm}^{-1}$. Find:

a) The zone separation *H*;

b) The diameter $2G_2$ of the SOLZ (n = 2).

2) Determine the Miller indices *hkl* for *all* of the lowest-order (smallest non-zero g_{hkl}) reflection(s), including the correct index signs, for an *fcc* crystal in the following zones:

a) $\begin{bmatrix} 10\overline{1} \end{bmatrix}$ ZOLZ, b) $\begin{bmatrix} 22\overline{1} \end{bmatrix}$ ZOLZ, c) $\begin{bmatrix} 120 \end{bmatrix}$ FOLZ, d) $\begin{bmatrix} 1\overline{2}1 \end{bmatrix}$ SOLZ

3) In a strong two-beam condition, the Bloch waves in a crystal have eigenfunctions:

$$\left| \psi^{(1)} \right\rangle = \begin{pmatrix} C_0^{(1)} \\ C_g^{(1)} \end{pmatrix} = \frac{1}{\sqrt{2}} \begin{pmatrix} 1 \\ -1 \end{pmatrix}, \ \left| \psi^{(2)} \right\rangle = \begin{pmatrix} C_0^{(2)} \\ C_g^{(2)} \end{pmatrix} = \frac{1}{\sqrt{2}} \begin{pmatrix} 1 \\ 1 \end{pmatrix}$$

The eigenvalues are $\gamma^{(1)} = -\frac{1}{2\xi_g}$ and $\gamma^{(2)} = \frac{1}{2\xi_g}$

Assume the operator for the imaginary part of the potential is:

$$\hat{\mathbf{A}}' = \frac{\alpha}{2} \cdot \begin{pmatrix} \frac{1}{\xi_0} & \frac{1}{\xi_g} \\ \frac{1}{\xi_g} & \frac{1}{\xi_0} \end{pmatrix}$$

where α is a small, dimensionless coefficient.

a) Find expressions for the imaginary components of the eigenvalues $\gamma'^{(1)}$ and $\gamma'^{(2)}$ using:

$$\gamma^{\prime\left(1,2\right)}=\left\langle \psi^{\left(1,2\right)}\left|\hat{\mathbf{A}}^{\prime}\right|\psi^{\left(1,2\right)}\right\rangle$$

b) Evaluate $\gamma^{(1,2)}$ and $\gamma'^{(1,2)}$, assuming $\xi_0 = 48 \text{ nm}$, $\xi_g = 96 \text{ nm}$, and $\alpha = 0.10$.

4) A two-beam dark-field image of an antiphase boundary using 200 KeV electrons shows a reversal from dark/light (w = 0) to light/dark ($w = \sqrt{3}$) contrast when the sample is tilted by 8.6 mrad from the Bragg condition.

For the reflection used ($g = 7.3 \text{ nm}^{-1}$), determine:

- a) the extinction distance ξ_{g} ;
- b) the magnitude of the Fourier coefficient U_{g} of the structure function.

5) An FFT from a high-resolution image of an amorphous material taken at 200 KeV with an objective lens spherical aberration coefficient of $C_s = 1.940$ mm has an intensity minimum at $u_n = 2.63$ nm⁻¹. The next minimum occurs at $u_{n+1} = 3.04$ nm⁻¹. Find the defocus Δf of the objective lens (in nm).

6) The object wave function below a sample is:

$$F(x) = 1 + iB \cdot \cos(2\pi gx)$$

The microscope transfer function in reciprocal space is given by $H(u) = A(u) \cdot e^{-i\chi(u)}$. Find the image wave function G(x) in direct space for the following cases:

a)
$$A(u) = \begin{cases} 1, & |u| \le g/2 \\ 0, & g/2 < |u| \\ 0, & g/2 < |u| \\ 0, & 3g/2 < |u| \\ 0, & 3g/2 < |u| \\ 0, & g/2 < |u| \end{cases}$$